

**Search Notes**

Application/Control No.

10/751,306

Examiner

Mark A. Chapman

Applicant(s)/Patent under  
Reexamination

MIYAKAWA ET AL.

Art Unit

1756

**SEARCHED**

Class	Subclass	Date	Examiner
399	228	12/8/2005	MC
	231		
430	45		
	47		
	111.4		
	107.1		
	126		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	12/8/2005	MC
reviewed related applications		